

C0402C180K5RACTU

Aliases (C0402C180K5RAC7867) SMD Comm X7R, Ceramic, 18 pF, 10%, 50 VDC, X7R, SMD, MLCC, Temperature Stable, Class II, 0402, 0.3 mm



General Information		
Series	SMD Comm X7R	
Style	SMD Chip	
Description	SMD, MLCC, Temperature Stable, Class II	
Features	Temperature Stable, Class II	
RoHS	Yes	
Termination	Tin	
Marking	No	
AEC-Q200	No	
Typical Component Weight	1.21 mg	
Shelf Life	78 Weeks	
MSL	1	

18 pF

1 kHz 1.0Vrms

Dimensions	
Chip Size	0402
L	1mm +/-0.05mm
W	0.5mm +/-0.05mm
Т	0.5mm +/-0.05mm
S	0.3mm MIN
В	0.3mm +/-0.1mm

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Т	0.5mm +/-0.05mm	
S	0.3mm MIN	
В	0.3mm +/-0.1mm	
Packaging Specifications		

W	0.5mm +/-0.05mm	Tolerance	10%
Т	0.5mm +/-0.05mm	Voltage DC	50 VDC
S	0.3mm MIN	Dielectric Withstanding Voltage	125 VDC
В	0.3mm +/-0.1mm	Temperature Range	-55/+125°C
		Temp. Coefficient	X7R
Packaging Specifications		Capacitance Change with	15%, 1kHz 1.0Vrms
Packaging	T&R, 180mm, Paper Tape	Reference to +25°C and 0 VDC Applied (TCC)	
Packaging Quantity	Quantity 10000	Dissipation Factor	2.5% 1 kHz 1.0Vrms
		Aging Rate	3% Loss/Decade Hour: Referee Time is 1000 Hours

Specifications

Measurement Condition

Capacitance

ckaging	T&R, 180mm, Paper Tape	Reference to +25°C and 0 VDC Applied (TCC)	·
ckaging Quantity 10000	10000	Dissipation Factor	2.5%1kHz1.0Vrms
		Aging Rate	3% Loss/Decade Hour: Referee Time is 1000 Hours
		Insulation Resistance	100 GOhms

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